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Examiner

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SEARCHED			
Class	Subclass	Date	Examiner
380	255, 259	12/28/2006	MDN
- 713	176	12/28/2006	MDN
455	410	12/28/2006	MDN

INTERFERENCE SEARCHED				
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SEARCH NOT (INCLUDING SEARCH		<u> </u>
	DATE	EXMR
Inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	12/28/2006	MDN
Text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	12/28/2006	MDN
Every claim has been reviewed for 35 USC non-statutory subject matter	12/28/2006	MDN
Consulted w/ M. Bookbinder on 101	12/28/2006	MDN [*]
Consulted w/ M. Heneghan on areas of search	12/28/2006	MDN
Google search	12/28/2006	MDN